

DOSEMI

IGBT

DG40H12T2

1200V/40A IGBT with Diode

General Description

DOSEMI IGBT Power Discrete provides ultra low conduction loss as well as low switching loss. They are designed for the applications such as general inverters and UPS.

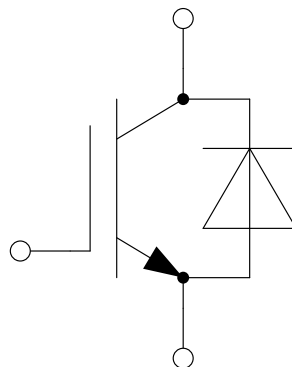
Features

- Low $V_{CE(sat)}$ Trench IGBT technology
- Low switching loss
- Maximum junction temperature 175°C
- $V_{CE(sat)}$ with positive temperature coefficient
- Fast & soft reverse recovery anti-parallel FWD

Typical Applications

- Solar Power
- Electronic welder
- Uninterruptible power supply

Equivalent Circuit Schematic



Absolute Maximum Ratings $T_C=25^\circ\text{C}$ unless otherwise noted**IGBT**

Symbol	Description	Value	Unit
V_{CES}	Collector-Emitter Voltage	1200	V
V_{GES}	Gate-Emitter Voltage Transient Gate-Emitter Voltage	± 20 -25/+30	V
I_C	Collector Current @ $T_C=25^\circ\text{C}$ @ $T_C=100^\circ\text{C}$	80 40	A
I_{CM}	Pulsed Collector Current t_p limited by T_{vjmax}	120	A
P_D	Maximum Power Dissipation @ $T_{vj}=175^\circ\text{C}$	535	W

Diode

Symbol	Description	Value	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	1200	V
I_F	Diode Continuous Forward Current @ $T_C=25^\circ\text{C}$ @ $T_C=100^\circ\text{C}$	78 40	A
I_{FM}	Diode Maximum Forward Current t_p limited by T_{vjmax}	120	A

Discrete

Symbol	Description	Values	Unit
T_{viop}	Operating Junction Temperature	-40 to +175	$^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to +150	$^\circ\text{C}$
T_S	Soldering Temperature, 1.6mm from case for 10s	260	$^\circ\text{C}$

IGBT Characteristics $T_c=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	$I_C=40\text{A}, V_{GE}=15\text{V}, T_{vj}=25^\circ\text{C}$		1.90	2.35	V
		$I_C=40\text{A}, V_{GE}=15\text{V}, T_{vj}=150^\circ\text{C}$		2.40		
		$I_C=40\text{A}, V_{GE}=15\text{V}, T_{vj}=175^\circ\text{C}$		2.60		
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=1.60\text{mA}, V_{CE}=V_{GE}, T_{vj}=25^\circ\text{C}$	5.0	5.8	6.5	V
I_{CES}	Collector Cut-Off Current	$V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_{vj}=25^\circ\text{C}$			200	μA
I_{GES}	Gate-Emitter Leakage Current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_{vj}=25^\circ\text{C}$			100	nA
R_{Gint}	Internal Gate Resistance			0		Ω
C_{ies}	Input Capacitance			7.15		nF
C_{oes}	Output Capacitance	$V_{CE}=25\text{V}, f=100\text{kHz}, V_{GE}=0\text{V}$		0.22		nF
C_{res}	Reverse Transfer Capacitance			0.11		nF
Q_G	Gate Charge	$V_{GE}=-15\dots+15\text{V}$		0.46		μC
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=600\text{V}, I_C=40\text{A}, R_G=12\Omega, V_{GE}=\pm 15\text{V}, L_S=40\text{nH}, T_{vj}=25^\circ\text{C}$		36		ns
t_r	Rise Time			92		ns
$t_{d(off)}$	Turn-Off Delay Time			92		ns
t_f	Fall Time			144		ns
E_{on}	Turn-On Switching Loss			5.66		mJ
E_{off}	Turn-Off Switching Loss		0.87		mJ	
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=600\text{V}, I_C=40\text{A}, R_G=12\Omega, V_{GE}=\pm 15\text{V}, L_S=40\text{nH}, T_{vj}=150^\circ\text{C}$		38		ns
t_r	Rise Time			92		ns
$t_{d(off)}$	Turn-Off Delay Time			104		ns
t_f	Fall Time			251		ns
E_{on}	Turn-On Switching Loss			6.72		mJ
E_{off}	Turn-Off Switching Loss		1.29		mJ	
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=600\text{V}, I_C=40\text{A}, R_G=12\Omega, V_{GE}=\pm 15\text{V}, L_S=40\text{nH}, T_{vj}=175^\circ\text{C}$		39		ns
t_r	Rise Time			102		ns
$t_{d(off)}$	Turn-Off Delay Time			113		ns
t_f	Fall Time			256		ns
E_{on}	Turn-On Switching Loss			6.81		mJ
E_{off}	Turn-Off Switching Loss		1.38		mJ	

Diode Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_F	Diode Forward Voltage	$I_F=40\text{A}, V_{GE}=0\text{V}, T_{vj}=25^\circ\text{C}$		1.95	2.40	V
		$I_F=40\text{A}, V_{GE}=0\text{V}, T_{vj}=150^\circ\text{C}$		2.00		
		$I_F=40\text{A}, V_{GE}=0\text{V}, T_{vj}=175^\circ\text{C}$		2.00		
t_{rr}	Diode Reverse Recovery Time	$V_R=600\text{V}, I_F=40\text{A},$ $-di/dt=320\text{A}/\mu\text{s}, V_{GE}=-15\text{V},$ $L_S=40\text{nH},$ $T_{vj}=25^\circ\text{C}$		286		ns
Q_r	Recovered Charge			3.73		μC
I_{RM}	Peak Reverse Recovery Current			17		A
E_{rec}	Reverse Recovery Energy			1.49		mJ
t_{rr}	Diode Reverse Recovery Time	$V_R=600\text{V}, I_F=40\text{A},$ $-di/dt=350\text{A}/\mu\text{s}, V_{GE}=-15\text{V},$ $L_S=40\text{nH},$ $T_{vj}=150^\circ\text{C}$		393		ns
Q_r	Recovered Charge			8.96		μC
I_{RM}	Peak Reverse Recovery Current			29		A
E_{rec}	Reverse Recovery Energy			3.69		mJ
t_{rr}	Diode Reverse Recovery Time	$V_R=600\text{V}, I_F=40\text{A},$ $-di/dt=400\text{A}/\mu\text{s}, V_{GE}=-15\text{V},$ $L_S=40\text{nH},$ $T_{vj}=175^\circ\text{C}$		396		ns
Q_r	Recovered Charge			9.98		μC
I_{RM}	Peak Reverse Recovery Current			33		A
E_{rec}	Reverse Recovery Energy			4.16		mJ

Discrete Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Min.	Typ.	Max.	Unit
R_{thJC}	Junction-to-Case (per IGBT)			0.280	K/W
	Junction-to-Case (per Diode)			0.559	
R_{thJA}	Junction-to-Ambient		40		K/W

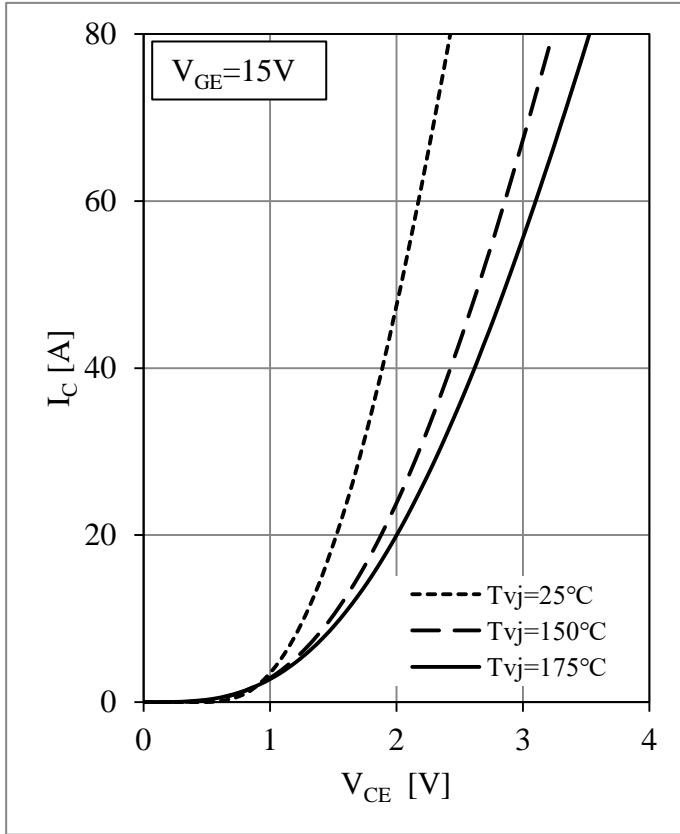


Fig 1. IGBT-inverter Output Characteristics

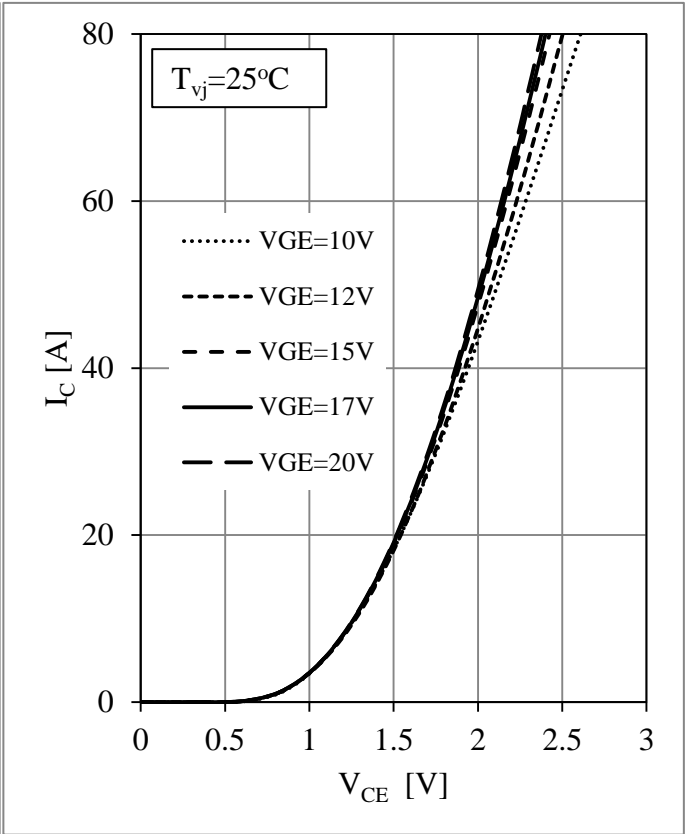


Fig 2. IGBT Output Characteristics

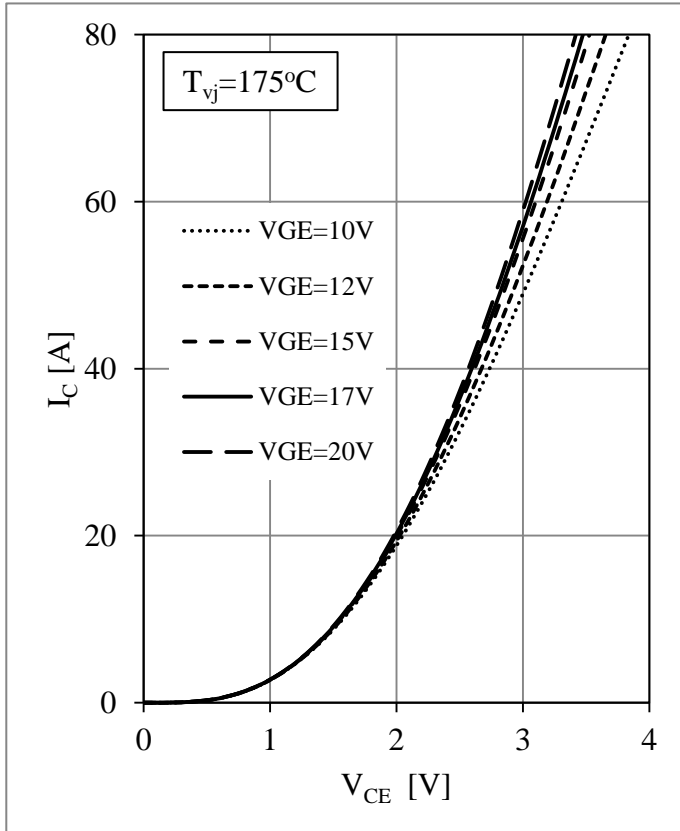


Fig 3. IGBT Output Characteristics

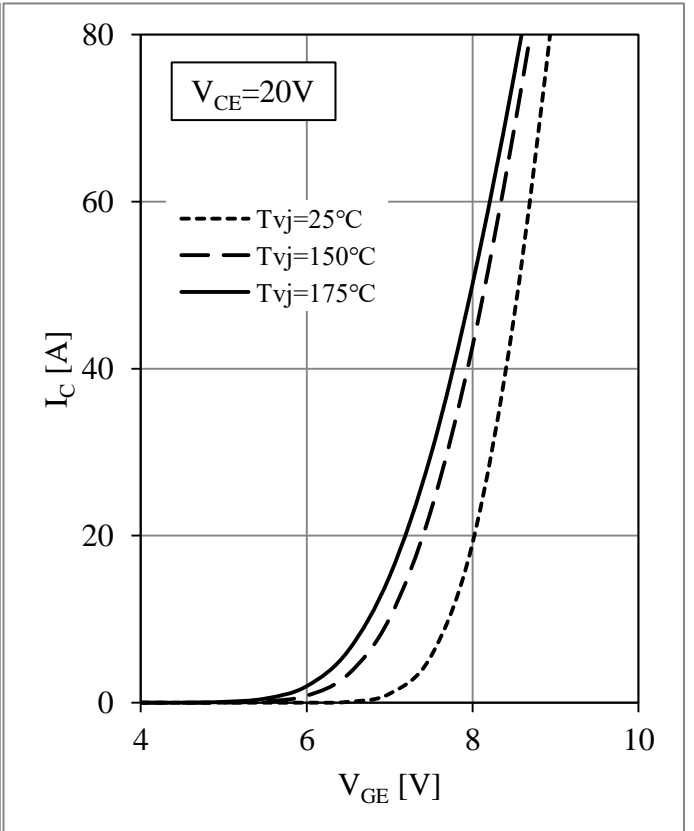


Fig 4. IGBT Transfer Characteristics

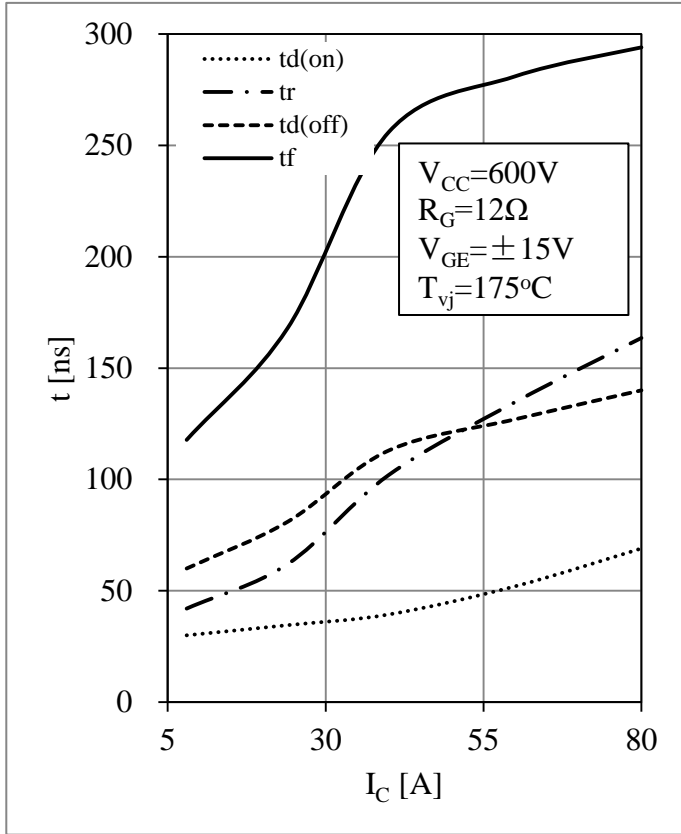


Fig 5. IGBT Switching Times as. I_C

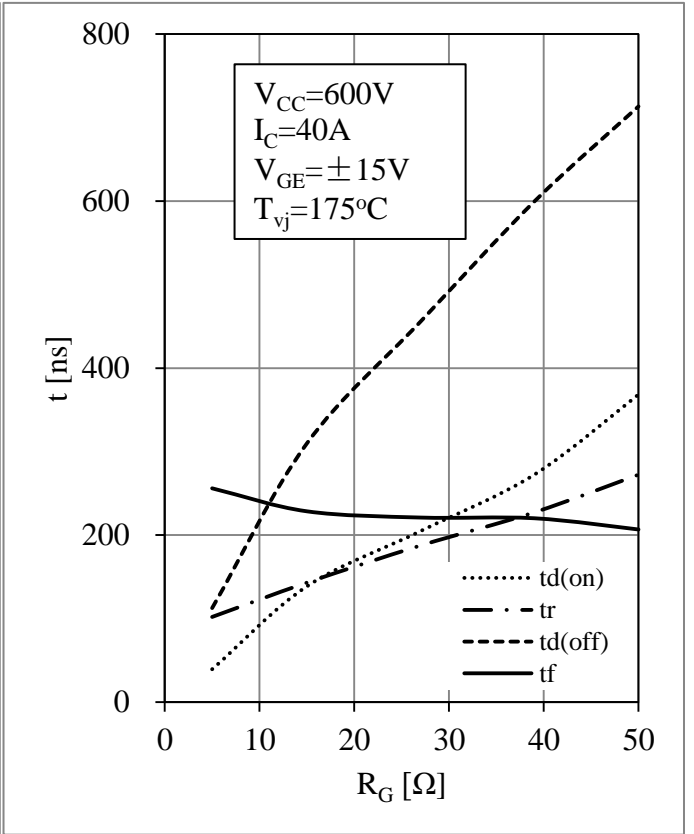


Fig 6. IGBT Switching Times as. R_G

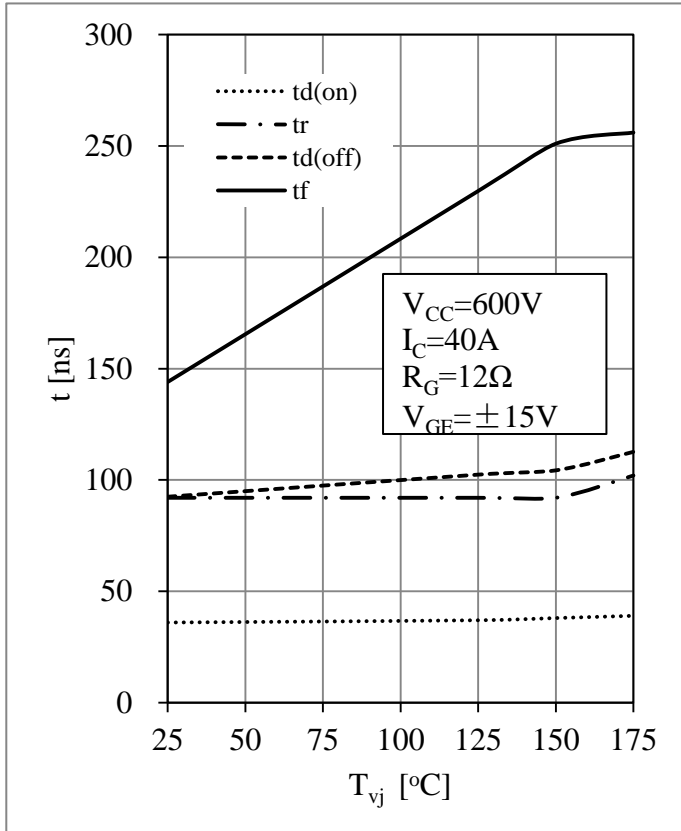


Fig 7. IGBT Switching Times vs. T_{vj}

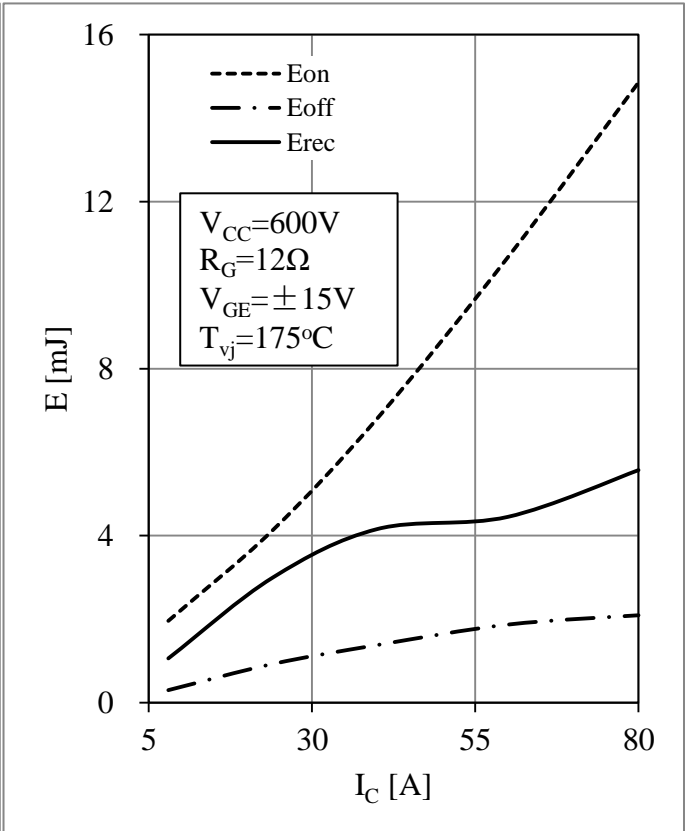


Fig 8. Switching Energy Loss vs. I_C

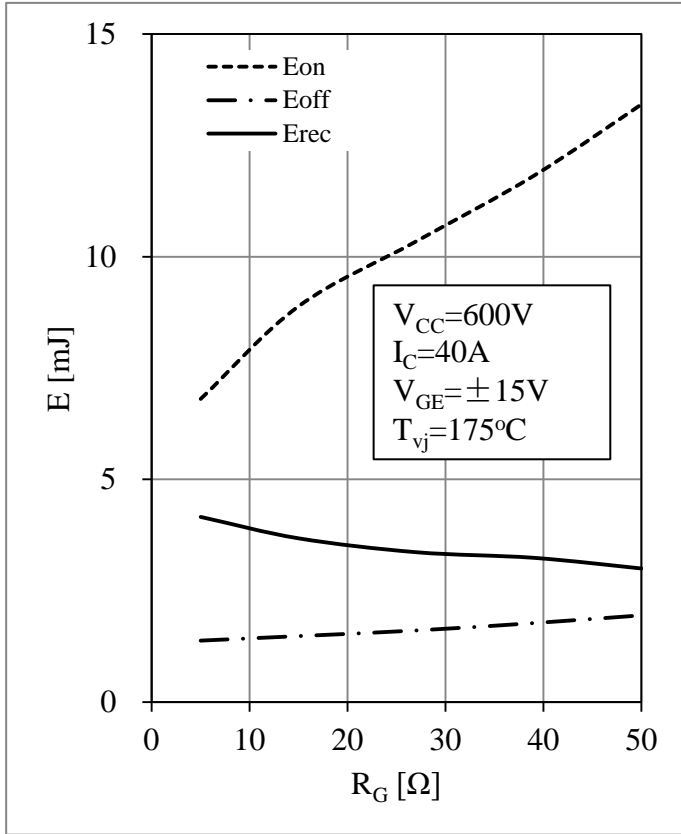


Fig 9. Switching Energy Loss vs. R_G

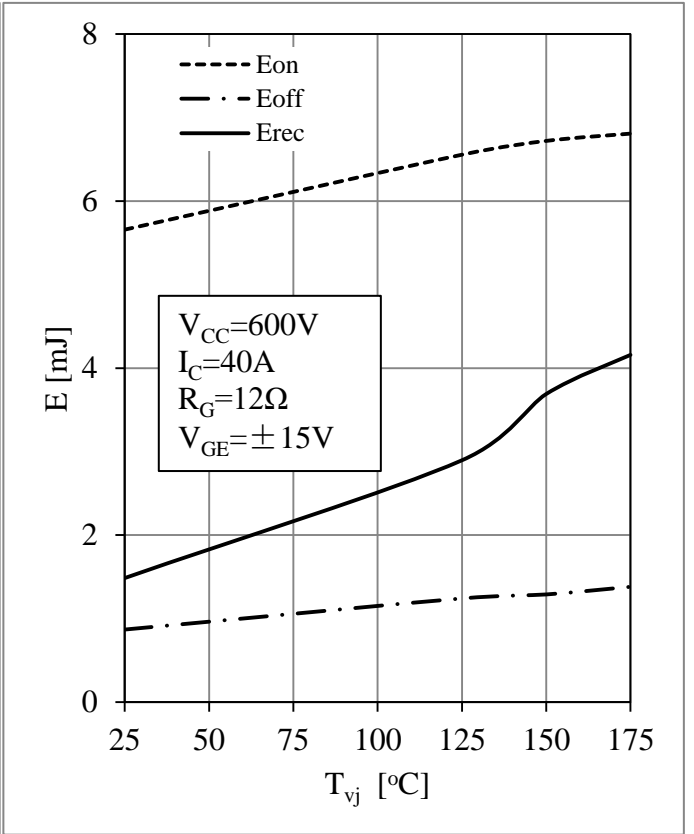


Fig 10. Switching Energy Loss vs. T_{vj}

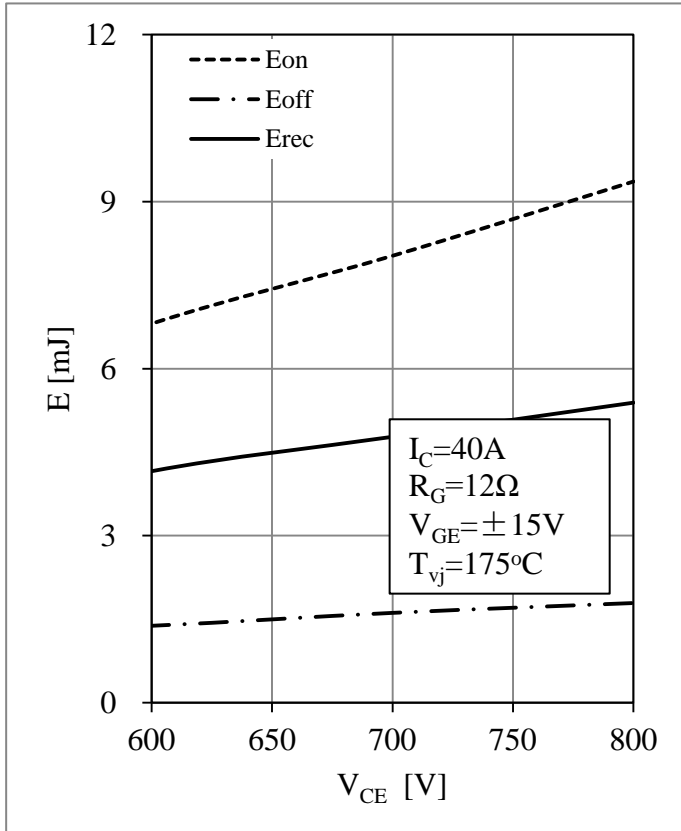


Fig 11. Switching Energy Loss vs. V_{CE}

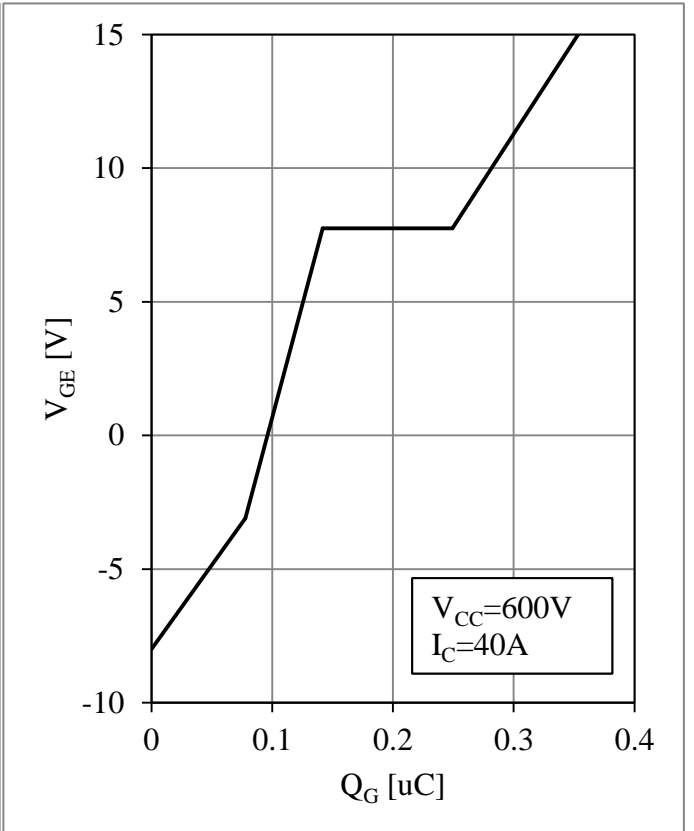


Fig 12. IGBT Gate Charge vs. V_{GE}

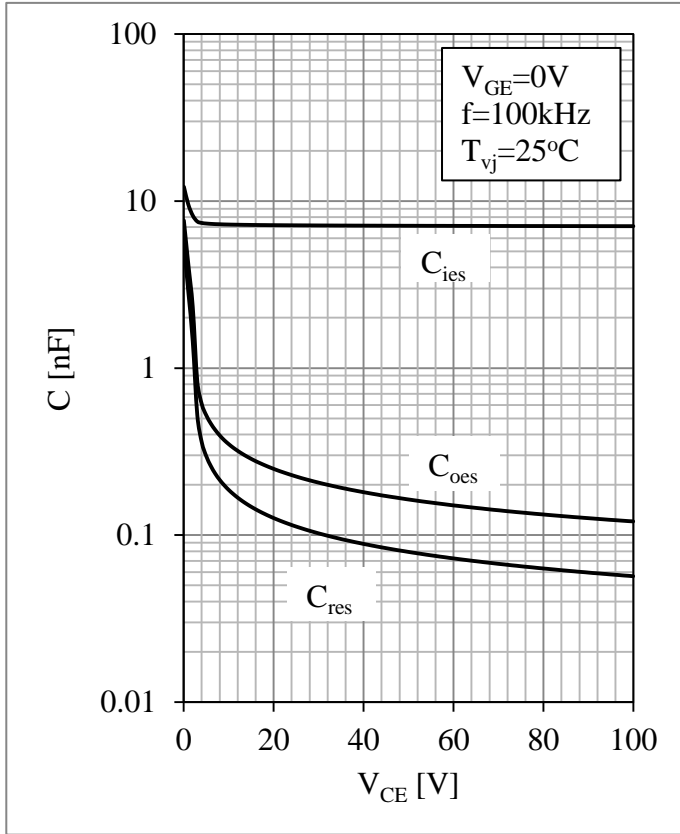


Fig 13. IGBT Capacity Characteristic

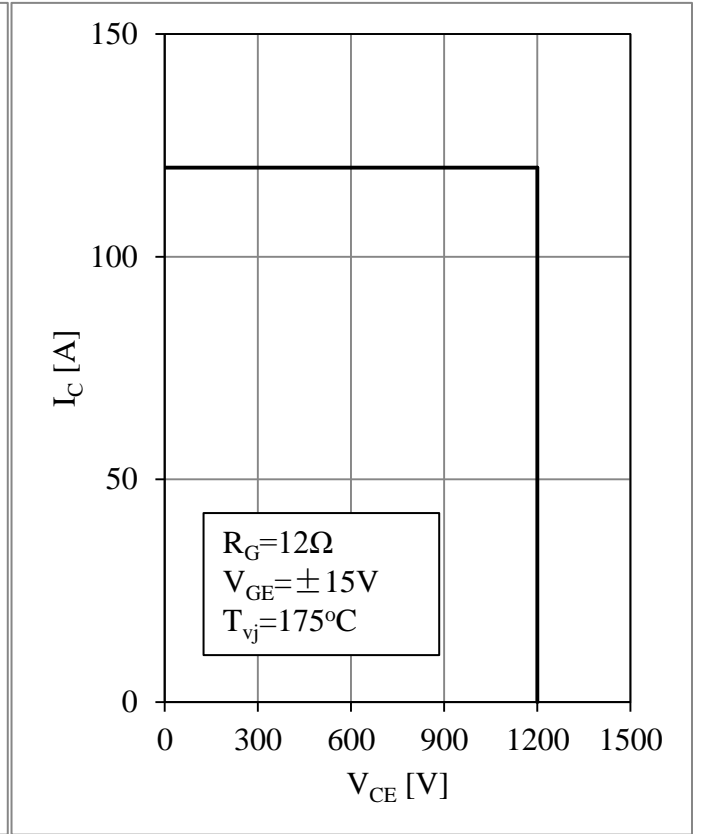


Fig 14. RBSOA

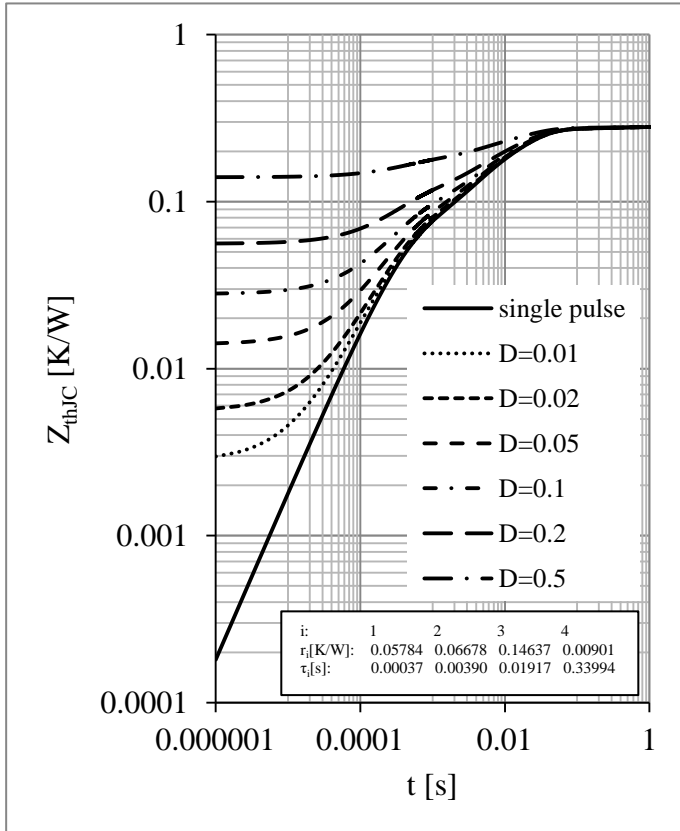


Fig 15. IGBT Transient Thermal Impedance

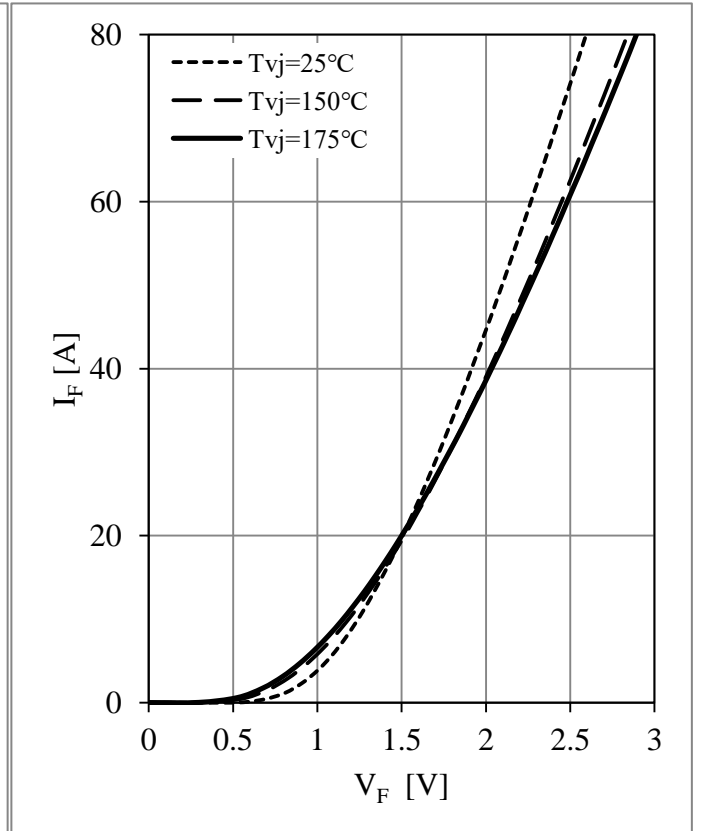


Fig 16. Diode Forward Characteristics

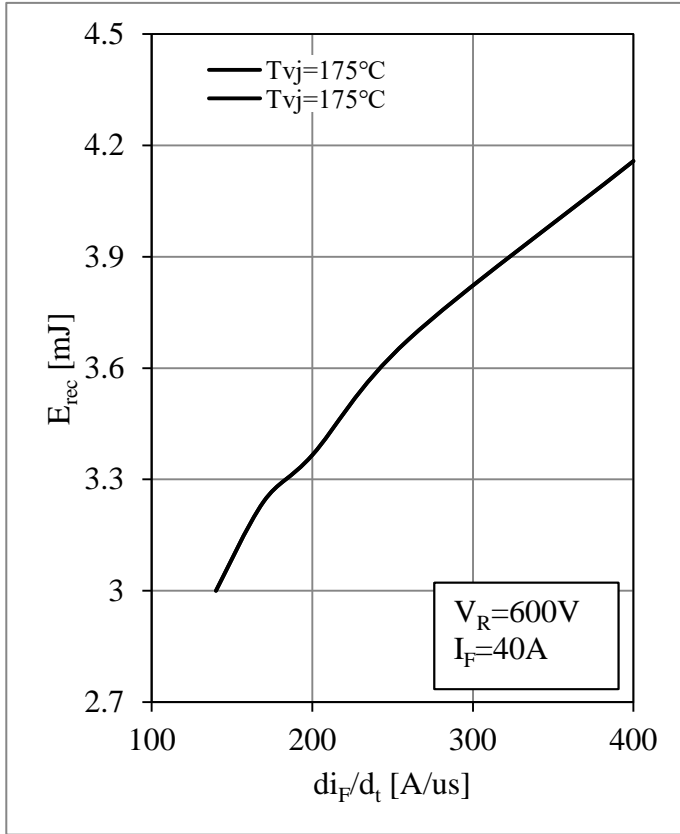


Fig 17. Reverse Recovery Time vs. di_F/d_t

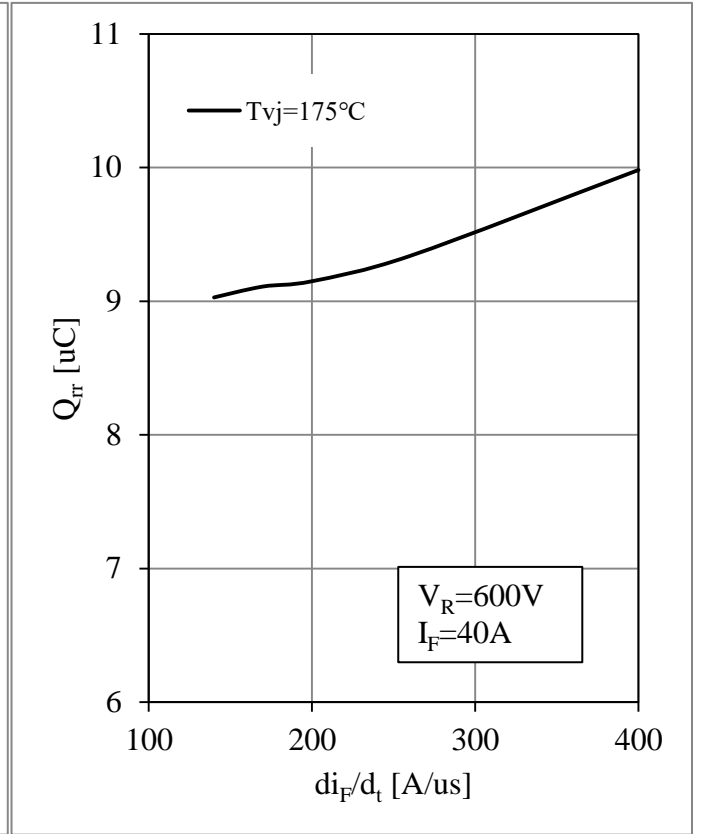


Fig 18. Reverse Recovery Charge vs. di_F/d_t

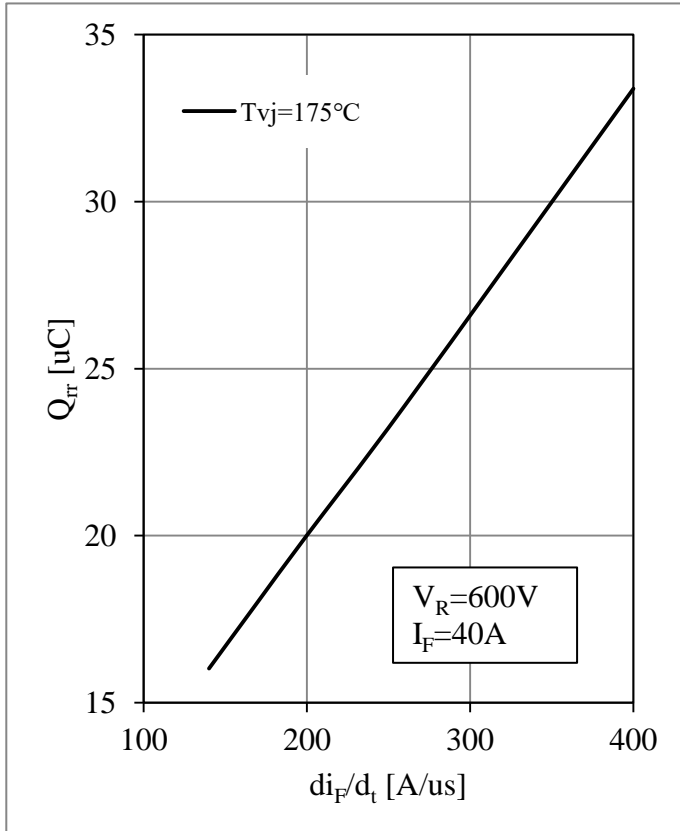


Fig 19. Reverse Recovery Current vs. di_F/d_t

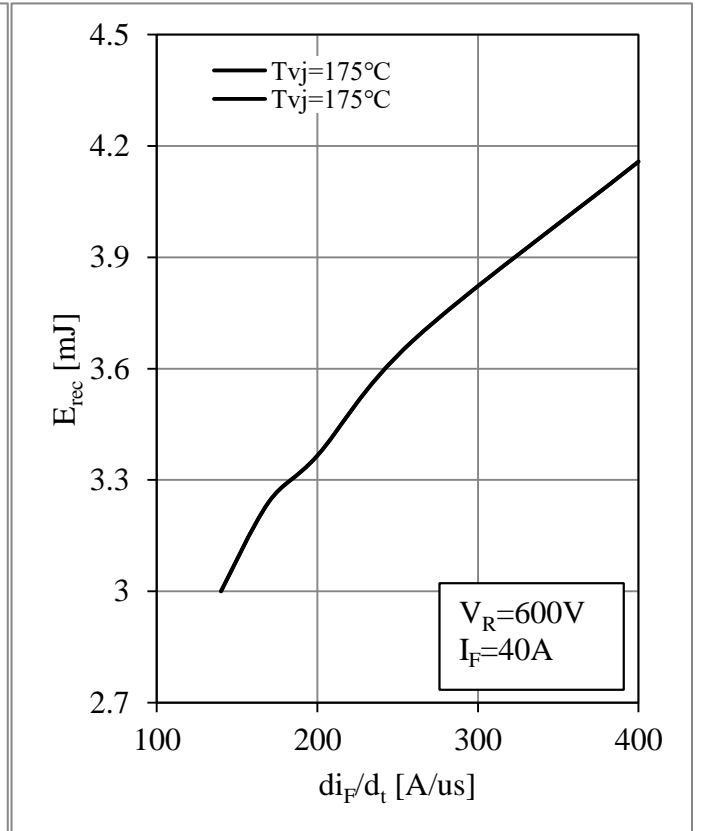


Fig 20. Reverse Energy Losses vs. di_F/d_t

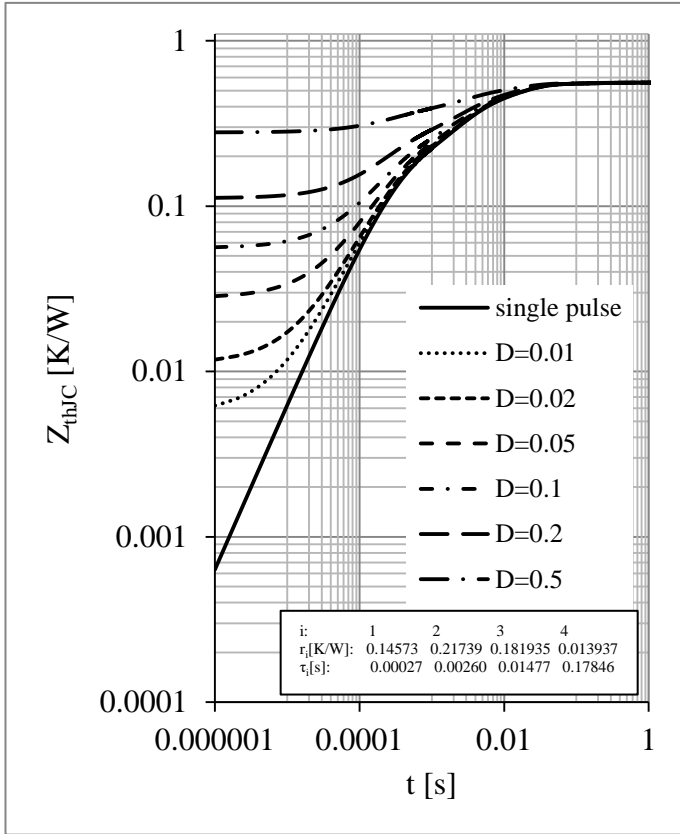
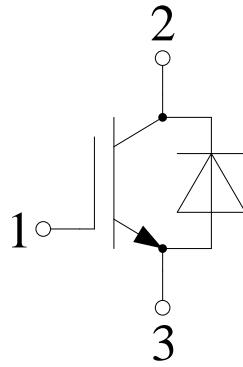


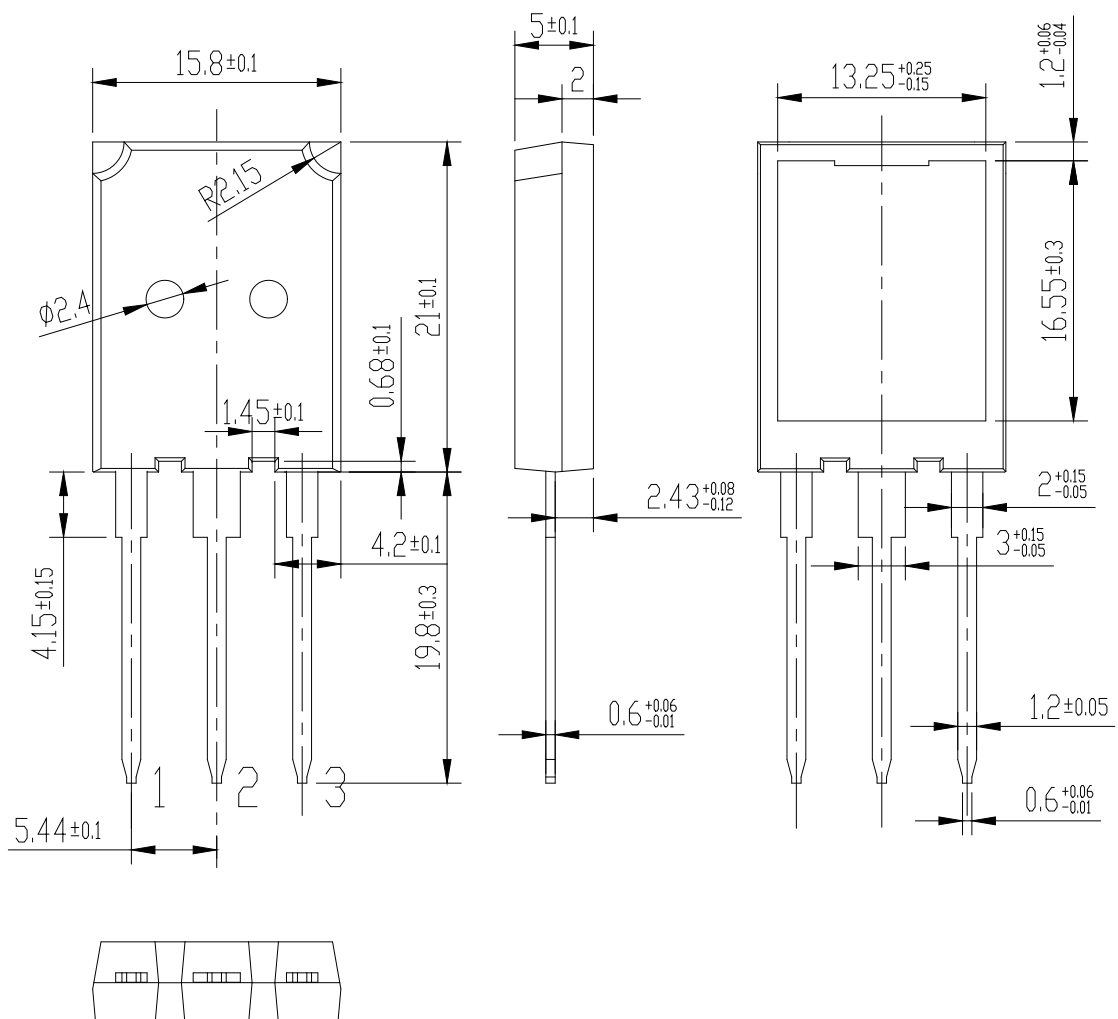
Fig 21. Diode Transient Thermal Impedance

Circuit Schematic



Package Dimensions

Dimensions in Millimeters



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